Hydrogeologie

Resistivity Methods

Jakob Wilk Institute of Earth and Environmental Sciences

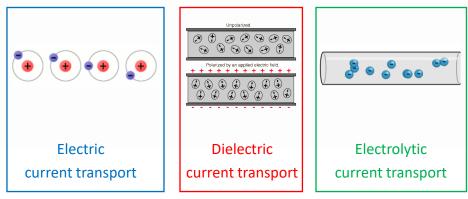






Basic Idea

• Measure electrical conductivities or resistivities using artificial fields.

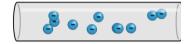


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Main Fields of Application

- Delimiting lithologic units and fault zones
- Determining depth and properties of aquifers
- Monitoring the impermeability of dams
- Exploration and monitoring of residual waste sites
- Monitoring the spread of pollutants
- Detecting potential slip surfaces (e. g., clay layers) in landslide-prone slopes

Mostly:



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Electric Field and Potential

• An electric field \vec{E} exerts a force

$$\vec{F} = q \vec{E}$$

on a charge q.

• In absence of time-dependent magnetic fields, the electric field can be represented by the gradient of the electric potential *U*:

$$\vec{E}(\vec{x}) = -\nabla U(\vec{x}) = -\begin{pmatrix} \frac{\partial}{\partial x_1} U(\vec{x}) \\ \frac{\partial}{\partial x_2} U(\vec{x}) \\ \frac{\partial}{\partial x_3} U(\vec{x}) \end{pmatrix}$$
$$\bigvee$$
$$\vec{F}(\vec{x}) = -q \nabla U(\vec{x})$$

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Electric Field and Potential

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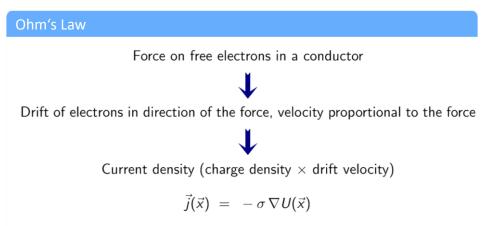
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$$\bigvee$$
$$\vec{F}(\vec{x}) = -q \nabla U(\vec{x})$$





- Named after Georg Simon Ohm, 1789-1854.
- The constant of proportionality σ is a property of the material and is denoted electrical conductivity.

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Conductivity and Resistivity

Conductivity σ $[\sigma] = \frac{1}{\Omega m} = \frac{s}{m}, \ \Omega = Ohm = \frac{V}{A}, \ S = Siemens = \frac{A}{V}$ Resistivity $\rho = \frac{1}{\sigma}$ $[\rho] = \Omega m$

Conductance and resistance refer to objects and not to materials and are measured in S and $\Omega,$ respectively.

(Semi)Conductors	$ ho~[\Omega m]$	Nonconductors	$ ho~[\Omega m]$
copper	$1.7 imes10^{-8}$	porcelain	10 ¹²
iron	10^{-7}	rubber	10 ¹³
silicium	2300	silica glass	$7.5 imes10^{17}$

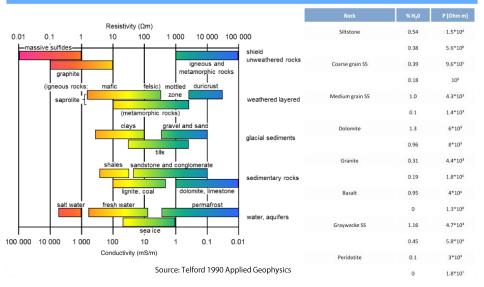


Conductivity / Resistivity of Rocks and Soils

- Rock forming minerals have very low conductivities.
- Many ores have considerably higher conductivities.
- The conductivity of pure water is rather low, but strongly increases by solving salts.

Solution	$ ho~[\Omega m]$
distilled water	10000
ocean water	0.5
10% copper sulfate	0.3
10 % sodium chlorite	0.08
10 % sulfuric acid	0.025
10 % hydrochloric acid	0.015

Conductivity / Resistivity of Rocks and Soils





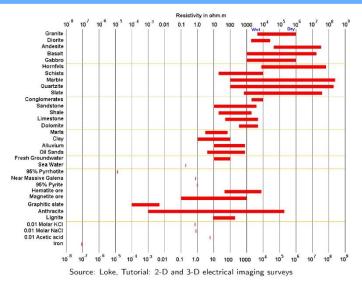
Conductivity / Resistivity of Rocks and Soils

Material	$ ho$ [Ω m]
halite	$10^{5}-10^{7}$
dry sand	10 ⁵
water satur. sand	1000 - 10000
quartzite	$3000 - 10^5$
ice	$1000 - 10^5$
granite	300 - 30000
sandy soils	150 - 7000
loamy soils	50 - 9000
clayey soils	20 - 4000

Material	$ ho$ [Ω m]
limestone	100 - 7000
marsh	30 - 700
glacial moraine	10 - 300
clay shale	10 - 1000
marl	5 - 200
loam	3 - 300
dry clay	30 - 1000
wet clay	1 - 30
silt	10 - 1000

Source: Beblo (Ed.), Umweltgeophysik

Conductivity / Resistivity of Rocks and Soils



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Conductivity / Resistivity of Rocks and Soils

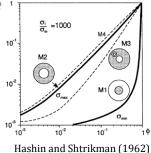
Thus, the total conductivity of a rock or a soil strongly depends on

- porosity
- water saturation
- connectivity of the pore space

$$\sigma_{\rm G} = a \ \varphi^n \ S^m \ \sigma_{\rm F}$$

with:

material conductivity (σ G), material properties (a, n, m), porosity (ϕ), conductivity of formation water ($\sigma_{\rm F}$) and pores actually containing water (S)





Conductivity / Resistivity of Rocks and Soils

Thus, the total conductivity of a rock or a soil strongly depends on

- porosity
- water saturation
- connectivity of the pore space
- pureness of the contained water (in return depends on the properties of the rock/soil)

Question

Which are the main dependencies of the hydraulic conductivity of an aquifer?

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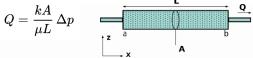
Conductivity / Resistivity of Rocks and Soils

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Question

Which are the main dependencies of the hydraulic conductivity of an aquifer? $\hfill L$



Dynamic viscosity (μ), Permeability (κ) and Pressure drop (Δp)

ER – Basic Terms

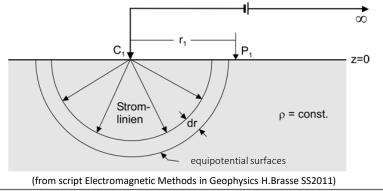
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The Principle of Subsurface Resistivity Measurement

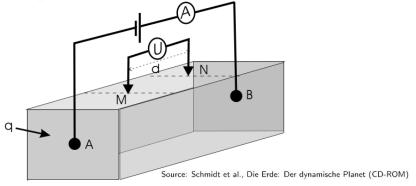
- Two current electrodes A und B are plugged into the ground, and a voltage is applied, generating a current *I* from A to B.
- Two potential electrodes M und N are plugged into the ground, and the voltage U between both is measured.





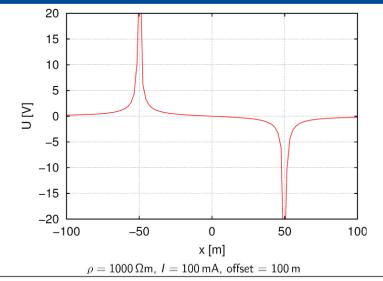
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The Potential between the Electrodes





Solutions of the Potential Equation in a Homogeneous Medium

Potential of a point source at the origin feeding a current *I*:

$$U(\vec{x}) = \frac{\rho I}{4\pi |\vec{x}|}$$

Potential of a point source at the point \vec{x}_A if the current is distributed in a half space only:

$$U(\vec{x}) = \frac{\rho I}{2\pi |\vec{x} - \vec{x}_A|}$$

Feeding in a current I at \vec{x}_A and extracting I at \vec{x}_B :

$$U(\vec{x}) = \frac{\rho I}{2\pi |\vec{x} - \vec{x}_{A}|} - \frac{\rho I}{2\pi |\vec{x} - \vec{x}_{B}|} \\ = \frac{\rho I}{2\pi} \left(\frac{1}{|\vec{x} - \vec{x}_{A}|} - \frac{1}{|\vec{x} - \vec{x}_{B}|} \right)$$

L



Arbitrary Electrode Configuration in a Homogeneous Half-Space

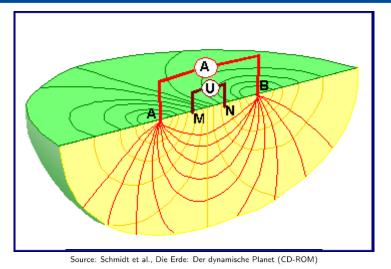
 Voltage between M and N is the difference of the potentials at x_M and x_N:

$$\begin{array}{lll} \mathcal{U} & = & \mathcal{U}(\vec{x}_{\mathcal{M}}) - \mathcal{U}(\vec{x}_{\mathcal{N}}) \\ & = & \displaystyle \frac{\rho I}{2\pi} \left(\frac{1}{|\vec{x}_{\mathcal{M}} - \vec{x}_{\mathcal{A}}|} - \frac{1}{|\vec{x}_{\mathcal{M}} - \vec{x}_{\mathcal{B}}|} - \frac{1}{|\vec{x}_{\mathcal{N}} - \vec{x}_{\mathcal{A}}|} + \frac{1}{|\vec{x}_{\mathcal{N}} - \vec{x}_{\mathcal{B}}|} \right) \\ & = & \displaystyle \frac{\rho I}{2\pi} \left(\frac{1}{r_{\mathcal{M}\mathcal{A}}} - \frac{1}{r_{\mathcal{M}\mathcal{B}}} - \frac{1}{r_{\mathcal{N}\mathcal{A}}} + \frac{1}{r_{\mathcal{N}\mathcal{B}}} \right) \end{array}$$

where r... are the distances between the respective electrodes.
Mostly, all electrodes are placed on a straight line.

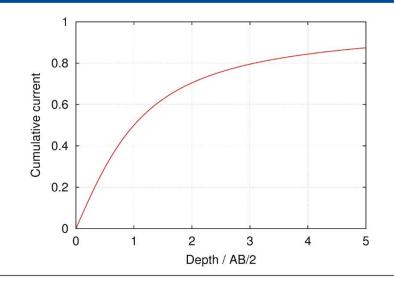


Dipole Field in a Homogeneous Half-Space



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Penetration Depth of the Current



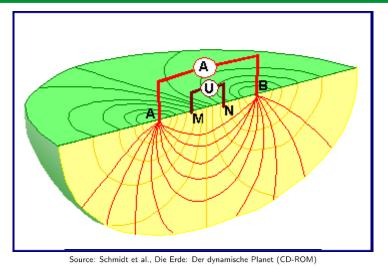
ER – Measuring Principle

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Dipole Field in a Homogeneous Half-Space



L



Arbitrary Electrode Configuration in a Homogeneous Half-Space

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Arbitrary Electrode Configuration in a Homogeneous Half-Space

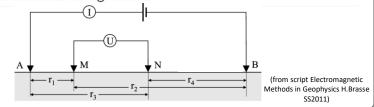
The resistivity of a homogeneous half-space can be determined according to

$$\rho = K \frac{0}{1}$$

with the geometric factor

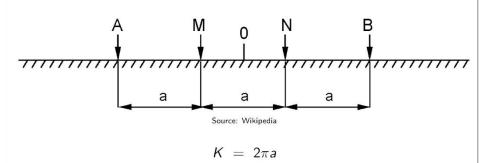
$$K = rac{2\pi}{rac{1}{r_{MA}} - rac{1}{r_{MB}} - rac{1}{r_{NA}} + rac{1}{r_{NB}}}$$

of the selected electrode configuration.





The Wenner (α) Configuration



Widely used for horizontal profiling (a fixed)

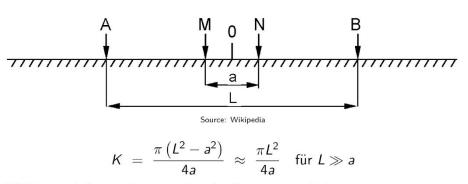


Variants of the Wenner Configuration

Configuration	Electrode sequence	Geometric factor
Wenner α	A-M-N-B	$K = 2\pi a$
Wenner β	A-B-M-N	${\sf K}={\sf 6}\pi{\sf a}$
Wenner γ	A-M-B-N	$K = 3\pi a$

Wenner α is the standard configuration (Wenner without further specification).



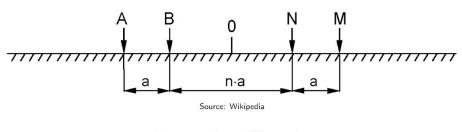


Widely used for vertical sounding (a fixed, L variable)

Caution: Sometimes L is used for AB/2 instead of the total offset AB.



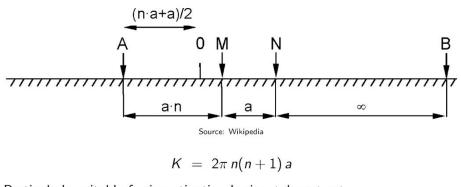
The Dipole-Dipole Configuration



$$K = \pi n(n+1)(n+2) a$$

Particularly suitable for profiling of small-scale structures, but a requires high power input.





Particularly suitable for investigating horizontal contrasts.





Surveys



Source: http://www.gfinstruments.cz



Source: http://www.lgm.de

Types of Resistivity Measurements

Results obtained for large offsets AB are more sensitive to the resistivities at greater depth than results obtained for small offsets.

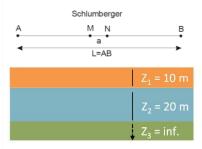
Vertical sounding: same location, but different offsets Horizontal profiling: constant electrode configuration used at different positions

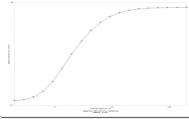
Resistivity tomography: variable location and variable electrode spacing

Various types of electrode configurations more or less suitable for different purposes



Surveys – Vertical Sounding

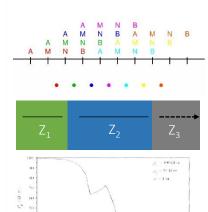






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Surveys – Horizontal Profiling/Constant Separation Traversing (CST)



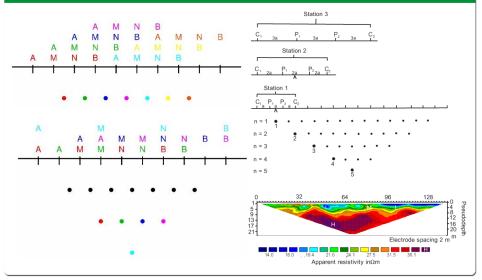
2 1 0 1 2



Source: Teaching material A. Henk

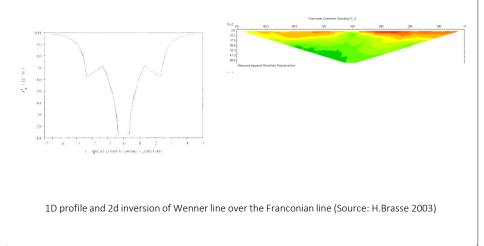


Surveys – Resistivity Tomography (ERT)





Surveys – ERT vs. Horizontal Profiling (CST)





Surveys – Resistivity Tomography (ERT)

- Several (up to some hundred) electrodes are plugged into the ground, either on a profile line or distributed in two dimensions.
- A programmable channel selector replays a defined sequence of usage of the electrodes as current or potential electrode pairs.
- The method is also called electric tomography, in particular if the electrodes are distributed in two dimensions.

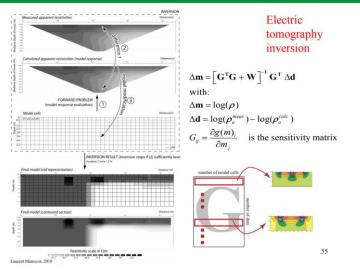
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Surveys – Resistivity Tomography (ERT) Apparent resistivity [Ωm] Pseudo depth [m] x [m]

The Wenner (α) configuration is most widely used, but all other configurations are also possible.



Surveys – Resistivity Tomography (ERT)





Surveys – Electrodes

Current and potential electrodes are technically identical. Criteria (in particular for the potential electrodes):

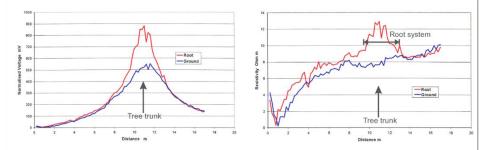
Contact resistance to the ground should be low.

Contact voltage should be small.

- Usage of nonpolarizable electrodes, e.g., copper core in CuSO₄ solution in a porous clay cylinder.
- Simple steel electrodes can be used with modern central units that are able to compensate contact voltages automatically.



Surveys – Horizontal Profiling



Comparison between planting the current electrode directly into a tree trunk versus into the ground near the tree's base: left - normalized potential, right – normalized resistivity profile

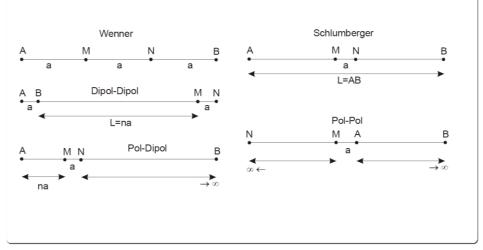
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Surveys – Electrodes

- Power source (constant current),
- voltmeter, and
- channel selector (for multi-electrode equipment)
- are mostly combined in one unit.
- Power up to about $1000\,W$
- Currents mostly between 10 mA and 1 A
- Voltages (between the current electrodes) up to some 1000 V
- Types of current: DC, low-frequency AC or switched DC with changing polarity



Surveys



ER - Data Analysis I

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Apparent Resistivity

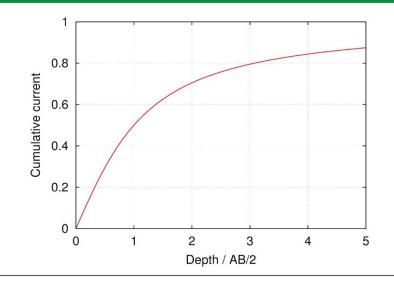
In a inhomogeneous medium,

$$o_a = K \frac{U}{I}$$

is called the apparent resistivity obtained from one measurement.

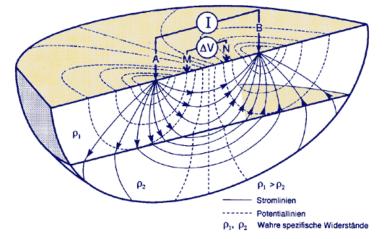
- ρ_a is the resistivity of a homogeneous medium that would yield the same result for the considered electrode configuration.
- ρ_a is not the real resistivity at any depth.
- The larger the offset is, the bigger is the contribution of deep regions to ρ_a.

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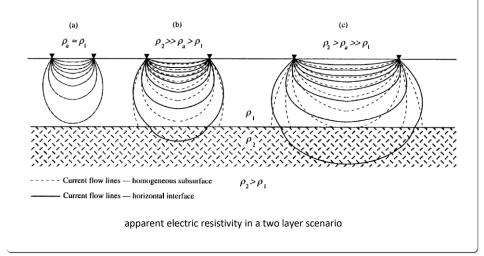
Vertical Sounding in the Two-Layer Case



Source: Knödel et al., Handbuch zur Erkundung des Untergrundes von Deponien und Altlasten, Vol. 3



Vertical Sounding in the Two-Layer Case





Vertical Sounding in the Two-Layer Case

Situation: Two homogeneous regions separated by a horizontal interface. Target properties:

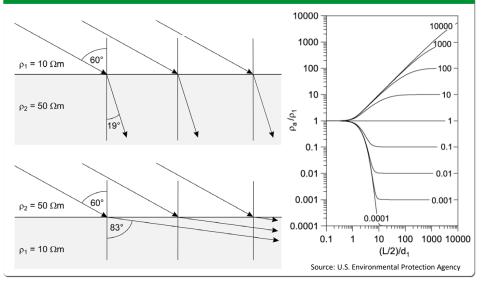
- $ho_1 =$ resistivity of the upper layer
- ρ_2 = resistivity of the lower region
 - d = thickness of the upper layer

Procedure: ρ_a is measured for several offsets AB (Wenner or Schlumberger configuration).

Data analysis can be performed graphically because $\frac{\rho_a}{\rho_1}$ only depends on $\frac{\rho_2}{\rho_1}$ and $\frac{AB/2}{d}$.



Vertical Sounding in the Two-Layer Case



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Scaling Behaviour

Rescaling the resistivities: If $\rho(\vec{x})$ is changed by the same factor λ everywhere, ρ_a changes by the same factor λ .

Spatial scaling: Stretching the entire system (including the positions of the electrodes) horizontally and vertically by a factor λ :

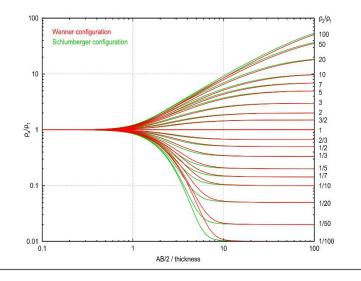
- If I is kept constant, all potentials change by the factor $\frac{1}{\lambda}$.
- K changes by the factor λ .

$\rho_{\textit{a}}$ remains the same.

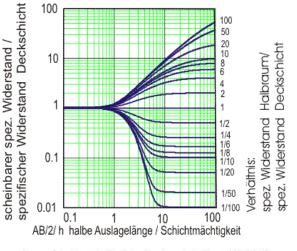
Consequence for the two-layer case: For any given electrode configuration at variable offset, $\frac{\rho_a}{\rho_1}$ depends only on $\frac{\rho_2}{\rho_1}$ and $\frac{AB}{d}$ (or $\frac{AB/2}{d}$ or $\frac{a}{d}$).



Wenner and Schlumberger Configurations in the Two-Layer Case



Graphical Data Analysis in the Two-Layer Case

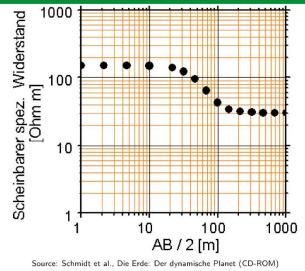


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Source: Schmidt et al., Die Erde: Der dynamische Planet (CD-ROM)

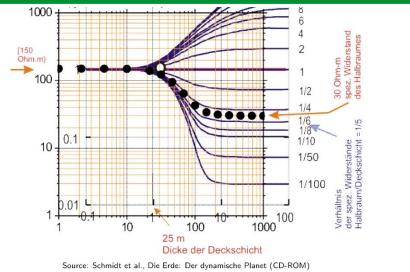


Graphical Data Analysis in the Two-Layer Case

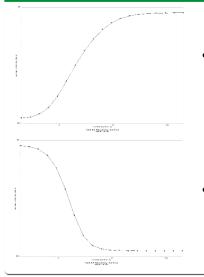




Graphical Data Analysis in the Two-Layer Case



Analysis in the Two-Layer Case



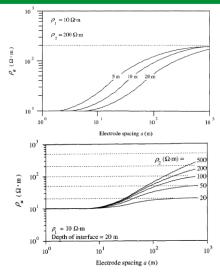
material with greater resistivity lies below the interface

 material with greater resistivity lies above the interface





Analysis in the Two-Layer Case

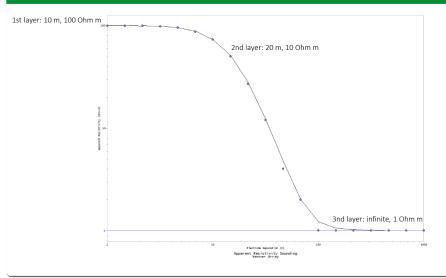


constant resistivity

constant depth

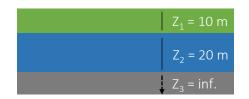


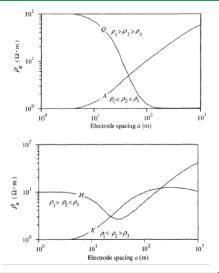
Analysis in the Two-Layer Case





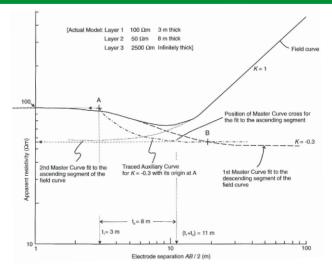
Analysis in the Three-Layer Case





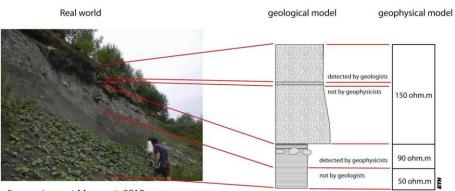


Analysis in the Three-Layer Case





Multi-Layer Case

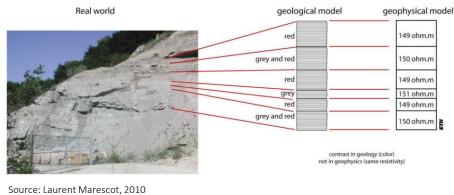


Source: Laurent Marescot, 2010



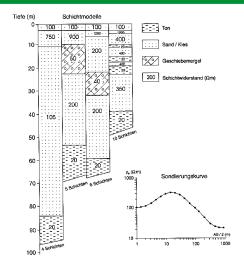
Multi-Layer Case

To characterize different material using geophysics, a contrast must exist (i.e. a difference in the physical properties)





Multi-Layer Case





2-Layer Case

- The result is more or less unique if a sufficient range of offsets is covered.
- The procedure can also be applied to gently dipping interfaces.
- This method has only historical and educational meaning. Practically, numerical inversion is preferred.

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N-Layer Case

- Must be inverted numerically. Resistivities and thicknesses of the layers are adjusted to obtain the best fit to the measured apparent resistivities.
- The uppermost layer has a strong influence on the result.
- A deep, thin layer with a high contrast in resistivity may have a similar effect as a thicker layer with a lower contrast in resistivity.
- In the standard inversion procedure of vertical sounding, the number of layers is given, and thicknesses and resistivities are adjusted.
 Different numbers of layers may lead to strongly different results.

↓

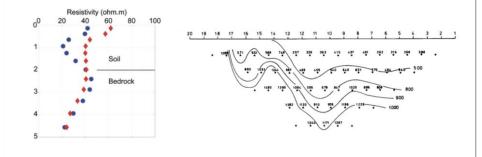
Quantitative analysis often hinges on independent information, e.g., from seismics or boreholes.

ER - Data Analysis II

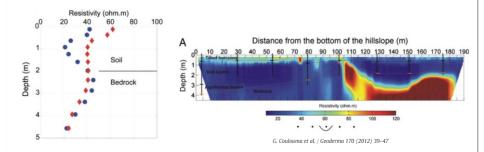
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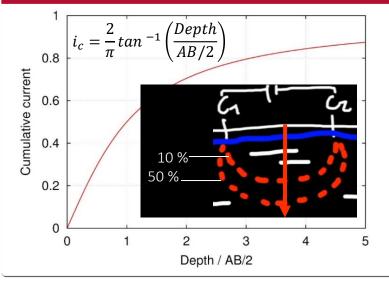




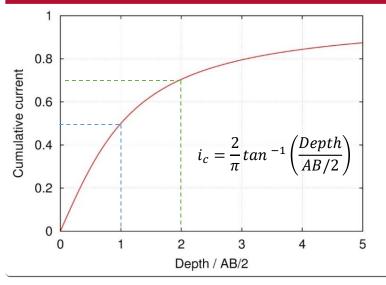














Penetration Depth of Current

Half of the current penetrates deeper than half of the total offset (AB/2), but

- the entire current must also pass shallow regions, and
- the potential electrodes are at the surface.

Typical depth of investigation is lower than AB/2.



Principle of the Sensitivity Analysis and Depth of Investigation Characteristic formula

$$\Delta \rho \sim \rho I$$

$$F(z) = \frac{2I_A}{\pi} \frac{z}{\left(r_{AM}^2 + 4z^2\right)^{1.5}}$$

$$F_4(z) = \frac{2zI_A}{\pi} \left[\left(r_{AM}^2 + 4z^2\right)^{-1.5} - \left(r_{AN}^2 + 4z^2\right)^{-1.5} - \left(r_{BM}^2 + 4z^2\right)^{-1.5} + \left(r_{BN}^2 + 4z^2\right)^{-1.5} \right]$$

Source: Butler, 2015 after Roy and Apparo, 1971



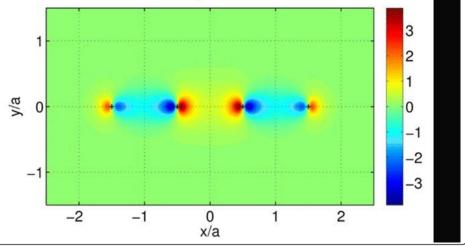
Principle of the Sensitivity Analysis and DIC formula

- Assume a given configuration of electrodes in a homogeneous medium with a resistivity ρ .
- Assume that ρ is increased (decreased) by a small amount δρ in a small region around a given point x in the subsurface.
- Determine how this small change affects the voltage between M and N if the current between A and B is given.



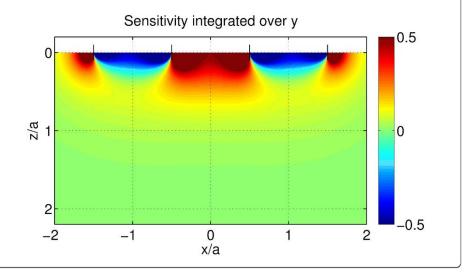
Sensitivity of the Wenner Configuration

Sensitivity at z/a = 0.1



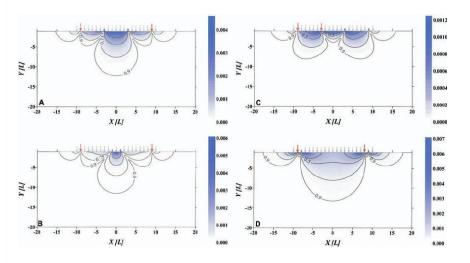


Sensitivity / Signal contribution section of the Wenner Configuration



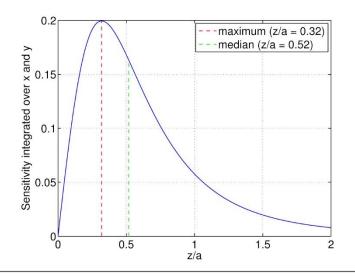


Sensitivity maps for Wenner, Schlumberger, double-dipole, & partial



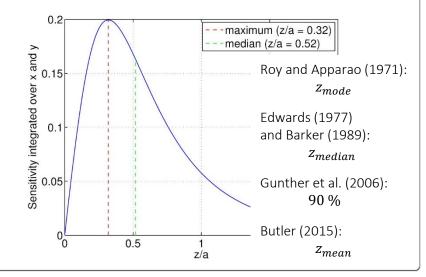


Sensitivity of the Wenner Configuration





Sensitivity of the Wenner Configuration





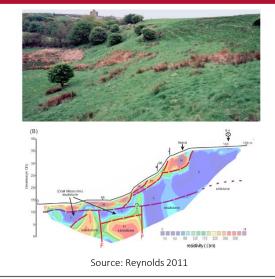
Sensitivity of the Wenner Configuration

- Sensitivity is always highest at low depth, in particular close to the electrodes M and N.
- Sensitivity changes its sign at low depths.
- Horizontally integrated sensitivity is highest at $z \approx 0.32$ a.
- Median of the horizontally integrated sensitivity distribution is at $z \approx 0.52$ a.

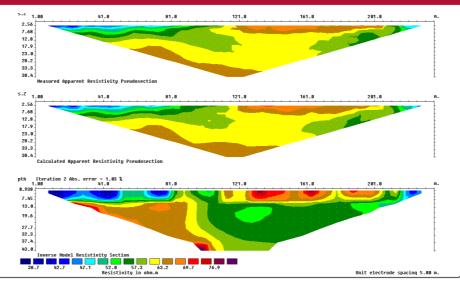
Regions with z < 0.52 a and z > 0.52 a contribute equally to the sensitivity in total.

0.52 a is often assumed as the typical depth of investigation.

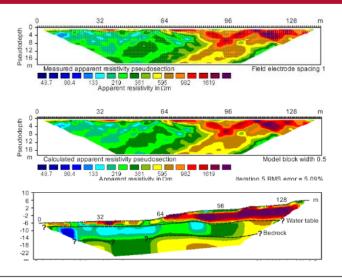






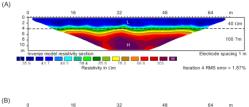


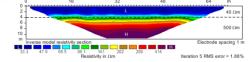


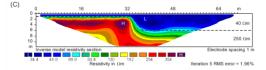




Pseudosections



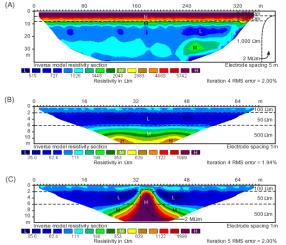




1. Normal fault

- 2. High contrast two-layer case
- 3. Low contrast two-layer case





- 1. Section with a lateral Discontinuity
- 2. Lateral homogenous three-layer section